

D2 PHASER

Diffraction Solutions

think forward

- Compact all-in-one desktop design
- Innovative high-end goniometer design
- Integrated PC / monitor
- DIFFRAC.SUITE software
- Leading detector technology



D2 PHASER - all-in-one desktop design

The whole world of X-ray diffraction on a desktop – D2 PHASER

What do you obtain when patented technologies, award-winning software, a fully functional PC with monitor and state-of-the-art detectors meet up with leadership in innovative X-ray diffraction? Perfect solutions for powder diffraction. And if it all fits onto a desktop, it is called D2 PHASER!

What enables this evolutionary leap to take place and how can the amazing performance of this space saving sensation actually be explained?

First of all, you develop an ultra compact goniometer, file a patent, complete the system with all the other components for autonomous operation and package the whole configuration together with a fully functional PC, monitor, keyboard and mouse, into a compact housing.

Second, you use the unique DIFFRAC.SUITE software for controlling the instrument and analyzing the data. Since its introduction the DIFFRAC software has developed into a high performance tool for the characterization of crystalline phases in research and industry.

Third, you use only the best components, for example the LYNXEYE detector. This state-of-the-art and extremely efficient 1-dimensional detector simultaneously captures a large angular range and radically reduces the measurement time: hours turn into minutes.

Combining all of these incredible innovations creates a desktop X-ray diffractometer which has the analytical performance and functions of a large instrument, but which is easy to transport and opens up the whole world of powder diffraction without a lot of infrastructure.

D2 PHASER – never before was desktop X-ray diffraction better, smaller and more powerful!



Status display LEDs



1-dimensional LYNXEYE detector



Transport handles



Internal chiller



USB and Ethernet connectors



D2 PHASER with opened front cover

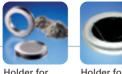


Integrated drawer for keyboard and mouse



X-ray on status LEDs







Airtight

holder for

sensitive

samples



Holders with various automated cavities sample preparation

I ow back clays ground holders for small sample amounts

filter samples environment-



D2 PHASER - slide-up front cover for sample loading, monitor remains active

- Phase identification and guantification
- Degree of crystallinity determination
- Phase properties (cell parameters, crystallite size, and lattice strain)
- Crystal structure analysis
- Wide variety of different sample holders of industrial standard dimension (Ø 51.5 mm)

D2 PHASER – the desktop giant!

Wishes come true - comprehensive, unique and non-destructive characterization of crystalline samples by means of X-ray diffraction (XRD) with the D2 PHASER.

Our D2 PHASER opens the door to modern XRD for you. This means qualitative and quantitative phase analysis, polymorphism investigation, the determination of crystallinity, all the way through to structure investigation - all of it fast, simple, efficient and with high quality.

It is not just its analytical performance that makes the D2 PHASER so revolutionary, but also its flexibility in handling very diverse samples. Different material properties require different sample preparations. Therefore, besides a series of standard sample holders made from PMMA or steel, the D2 PHASER also offers holders for small sample amounts, low-absorbing and weakly diffracting samples, for filters, for environmentsensitive samples and for examining materials that tend to show a preferred orientation.

LYNXEYE fast-lane edition

What makes the D2 PHASER absolutely unique is the integration of the world's leading 1-dimensional detector for X-ray powder diffraction: Our LYNXEYE.

With a performance enhancement in terms of intensity by a factor of more than 150, the D2 PHASER is actually playing in the top class. Additionally the LYNXEYE allows suppression of sample fluorescence providing an excellent peak-to-background ratio even for strongly fluorescent samples, eliminating any need for secondary monochromators.

D2 PHASER – X-ray diffraction in a new dimension!







Research & Education



Environment





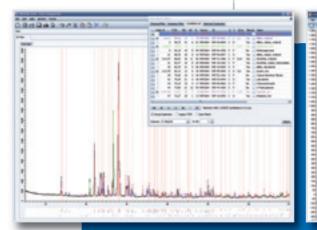
All-in one is everything you need – D2 PHASER

Can XRD – the best method for phase characterization – really produce high quality data without the need for a corresponding infrastructure?

Yes! With our D2 PHASER a new era begins. All that is required is a simple domestic wall socket and you can start producing outstanding analytical results: Plug 'n Analyze. Since it is a desktop system it requires only a minimum amount of space and is in no way inferior to a large system in terms of its analytical performance. Resolution, angular accuracy and data statistics set new standards in this class of analytical instruments; data quality which you can rely on and with which even complex questions can be answered.

Our D2 PHASER is a transportable all-in-one instrument that requires no additional cooling water or PC peripherals. This means that there is nothing to prevent it from being used outdoors: simply switch-on a power generator, plug in the connector and start measuring!

D2 PHASER – X-ray diffraction tool for everyone – everywhere!



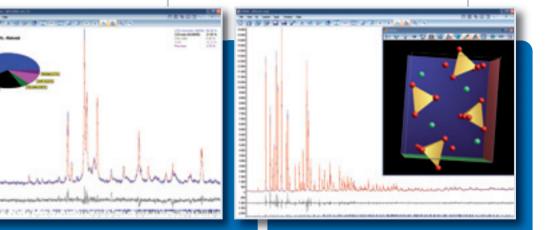
DIFFRAC.EVA

- Qualitative phase identification
 ICDD PDF2 and PDF4
- User-defined databases
- Semi-quantitative phase analysis
 RIR method
- Combined XRD-XRF analysis
- Publication-ready reporting

DIFFRAC.TOPAS

Quantitative Analysis

- Quantitative phase analysis
 Crystalline phases
 Amorphous phases
- Degree of crystallinity determination
- Spiking method
- PONKCS method



DIFFRAC.TOPAS Structure Analysis

- Indexing (LSI and LP-Search methods)
- Pawley and LeBail fitting
- Rietveld structure refinement
- Ab-initio structure determination
 Simulated annealing
- Charge Flipping
- 3D Fourier analysis
- Microstructure analysis

- Minimal electrical power consumption (650 W)
- No cooling water supply
- No significant tube ageing practically endless tube lifetime
- Minimal space required

D2 PHASER – dataquality, functionality and safety without any compromises

Our D2 PHASER delivers uncompromisingly good and reliable analyses. The strict quality standards of our entire product range are applied to the assembling, testing and certified safety of the D2 PHASER!

We give you our word: Good Diffraction Practice and Best Data Guarantee!

Safety assurance:

Each instrument always complies with the world's highest statutory requirements regarding X-ray safety, machine and electrical safety. This certainty is obtained after stringent scrutiny by independent institutions.

Two independent, fail-safe safety circuits and "X-ray On" monitors guarantee that the most recent radiation and personal safety regulations are observed.

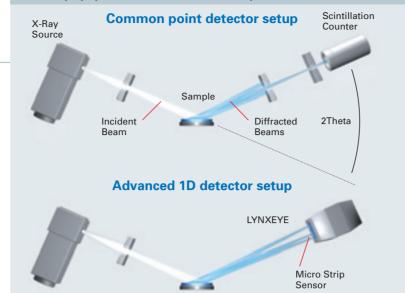
Alignment guarantee:

The D2 PHASER is pre-aligned at delivery. Every single instrument must pass our strict test procedure, which is based on the internationally accepted reference material corundum. The corundum reference is supplied with the instrument, so you can check your instrument at any time.

Detector guarantee:

We guarantee that our 1-dimensional LYNXEYE is absolutely faultless! This is due to Bruker AXS' unique detector design. By integrating the LYNXEYE detector in the D2 PHASER it becomes the fastest and most efficient desktop diffractometer in the world.

The best in its class: the D2 PHASER. Shake on it!



Instrument alignment – a sound base for accuracy

Unrivaled resolution

SRM 660a

5000-

4000-

3000-

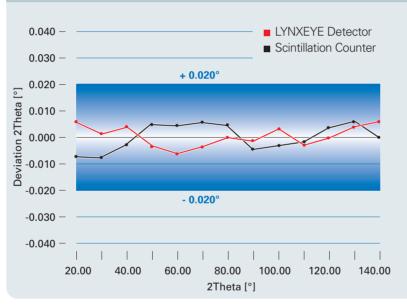
2000-

1000-

0

29.90

Coun



2Theta [°]

30.50

30.70

30.90

30.10

30.30

FWHM = 0.0421° 20

In an XRD experiment performed on polycrystalline material the incident X-ray beam is diffracted by innumerous crystallites in specific 2Theta directions.

To record the exact 2Theta positions a narrow slit in front of a point detector is required.

- The LYNXEYE literally provides more than 150 integrated slits, allowing more than 150 2Theta positions to be recorded simultaneously.
- Instrument alignment ≤ ± 0.02° 2Theta over the whole angular range – guaranteed!
- Why is this important? Accurate and verifiable instrument alignment is a basic requirement for accurate and reliable phase identification or structure analysis.

Very small peak width of

less than 0.05° 2Theta

XRD measurement of

LaB₆ (NIST SRM 660a)

with LYNXEYE detector;

0.1° divergence and 1.5°

Good instrument resolution

is a prerequisite to resolve

peaks in complex powder

Why is this important?

overlapping diffraction

Soller slit.

patterns.

obtained by high-resolution

Plug'n Analyze:

No installation

No alignment

■ No instrument

configuration

■ No infrastructure

requirements

■ No pre-installation

A simple domestic wall

socket is all you need

All-in-one analytics:

- Simple sample loading
- Industrial standard sample holders
- Theta/Theta geometry, horizontal samples
- Fully-fledged integrated PC
- On-site and remote operation

XRD on polycrystalline material - more intensity with LYNXEYE detector

LYNXEYE detector:

- Intensity increases by a factor of more than 150
- 100% working strips at delivery – guaranteed
- Energy discrimination for sample fluorescence suppression
- Scanning and snapshot mode
- Angular coverage
 5.5° 2Theta





X-ray source:

- Common sealed X-ray tube design
- Low power load no tube ageing
- Virtually infinite tube lifetime
- Cr, Co, Cu radiation

Desktop design:

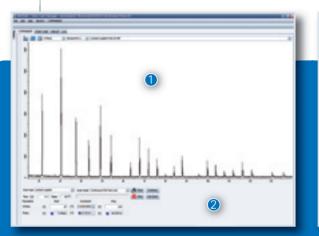
- Minimum space requirements
- Handles for convenient transportation
- Maximum X-ray safety with radiation level significantly below 1µSv/h
- Clearly visible warning and operating elements
- Alignment accuracy better than ±0.02° 2Theta
 – guaranteed





Island-mode:

- Internal cooling system
- High speed ethernet connection
- 2 USB ports



Easy-mode

- Real-time measurement display
- 2) Straightforward selection of scan parameters:
 - Angular range
 - Step size
 - Measurement time

Expert-mode

- ③ Full access to all settings:
 User management
 Database maintenance
 Instrument configuration
 Service tools
- ④ Full access to all
 - instrument parameters: - Drives - Detector settings - Generator settings

- Compatible with the entire Bruker AXS' Diffraction Solutions family
- Fully network capable
- Support of different user levels and modes
- EVA powerful phase identification
- TOPAS sophisticated quantitative
- 10 phase and structure analysis

The ultimate in ease-of-use – D2 PHASER with DIFFRAC.SUITE

X-ray analysis has never been easier! Even inexperienced users produce perfect measurements from the very beginning thanks to the DIFFRAC.SUITE Easy-mode.

This is how X-ray analysis works in the Easy-mode:

Select COMMANDER plug-in, enter measurement time and angular range and start. That's all!

If a method has already been defined, it goes even faster:

Select START JOBS, click on Method and off you go!

It goes without saying that the software solutions of our DIFFRAC.SUITE go beyond this. In Expert-mode the full scope of functions is available. Using the COMMANDER, CONFIGURATION and TOOLS plug-in the expert has control over administration of experimental databases, user rights and all the way through to the Audit Trail. Everything on the system works in a safe, simple and reliable way.

DIFFRAC.SUITE – performance made-to-measure: easy for anyone to operate, full functionality and control for experts. Integrated within a networked world.

Our D2 PHASER is fully network capable. This enables XRD experts in the central laboratory to access the data that has been collected, no matter if they are next door or at the other end of the world. Use the D2 PHASER where it is needed – on-site – and you will save time and money!

The D2 PHASER is a full-blown diffractometer: its measured data is fully compatible with all of our DIFFRAC.SUITE solutions. The familiar world of search/match and structure databases, EVA, TOPAS,... all of this is available to the XRD specialist for identifying, quantifying and determining the characteristics of the crystalline phases.

D2 PHASER – Welcome to the world of Bruker AXS!



All-in-one analysis

| Technical Data | |
|---|--|
| Geometry | Theta / Theta |
| Max. useable angular range (depending on detector) | -3 160 ° 2Theta |
| Accuracy | \pm 0.02° throughout the entire measuring range |
| Achievable peak width | < 0.05° |
| Alignment | Not needed, factory aligned |
| X-ray wavelengths | Cr / Co / Cu, standard ceramic sealed tube |
| X-ray generation | 30 kV / 10 mA |
| Detectors | Scintillation counter 1-dimensional LYNXEYE |
| Instrument type | Portable desktop |
| Exterior Dimension | 61 x 60 x 70 cm (h x d x w) 24.02" x 23.62" x 27.56" |
| Weight | 95 kg |
| Power supply | 90 – 250 V |
| External cooling water supply | None |
| Computer | Built-in Optional additional PC connected via LAN interface |
| Interfaces | 2 x USB and 1 x LAN |

Bruker AXS GmbH

Karlsruhe, Germany Tel. +49 (7 21) 5 95-28 88 Fax +49 (7 21) 5 95-45 87 info@bruker-axs.de

Bruker AXS Inc.

Madison, WI, USA Phone +1 (800) 234-XRAY Phone +1 (608) 276-3000 Fax +1 (608) 276-3006 info@bruker-axs.com

D2 PHASER™, DIFFRAC[®], LYNXEYE™, Plug'n Analyze™ are trademarks of Bruker AXS